

<b>Notice of References Cited</b>	Application/Control No. 10/826,965	Applicant(s)/Patent Under Reexamination HESSE ET AL.	
	Examiner Thao T. Tran	Art Unit 1711	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,463,026	10-2002	Anderson, Collin D.	720/719
*	B	US-7,033,668	04-2006	Schumann et al.	428/356
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 6279741 A2	10-1994	Japan	Ikuma, Seichiro	C09J 7/02
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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